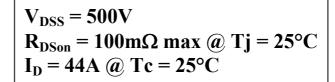
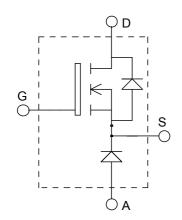


# ISOTOP® Buck chopper MOSFET Power Module





### **Application**

- AC and DC motor control
- Switched Mode Power Supplies

#### **Features**

- Power MOS V<sup>®</sup> MOSFETs
  - Low R<sub>DSon</sub>
  - Low input and Miller capacitance
  - Low gate charge
  - Fast intrinsic diode
  - Avalanche energy rated
  - Very rugged
- ISOTOP® Package (SOT-227)
- Very low stray inductance
- High level of integration

#### **Benefits**

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Very rugged
- Low profile
- RoHS Compliant

### Absolute maximum ratings

ISOTOP®

Absolut	c maximum ratings			
Symbol	Parameter	Max ratings	Unit	
$V_{ m DSS}$	Drain - Source Breakdown Voltage	500	V	
Ţ	Continuous Drain Current $T_c = 25^{\circ}C$	44		
$I_{D}$	$T_c = 80^{\circ}C$	33	A	
$I_{DM}$	Pulsed Drain current	176		
$V_{GS}$	Gate - Source Voltage	±30	V	
R <sub>DSon</sub>	Drain - Source ON Resistance	100	mΩ	
$P_D$	Maximum Power Dissipation $T_c = 25^{\circ}C$	450	W	
$I_{AR}$	Avalanche current (repetitive and non repetitive)	44	A	
$E_{AR}$	Repetitive Avalanche Energy	50	mJ	
$E_{AS}$	Single Pulse Avalanche Energy	2500	1113	
$IF_{AV}$	Maximum Average Forward Current Duty cycle=0.5 Tc = 80°C	30	A	
$IF_{RMS}$	RMS Forward Current (Square wave, 50% duty)	39	A	

CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.



### All ratings @ $T_j = 25$ °C unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 500V$ $T_j = 25^{\circ}C$			25	μΑ
		$V_{GS} = 0V, V_{DS} = 400V$ $T_j = 125^{\circ}C$			250	
R <sub>DS(on)</sub>	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 22A$			100	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{GS} = V_{DS}$ , $I_D = 2.5 \text{mA}$	2		4	V
$I_{GSS}$	Gate – Source Leakage Current	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA

**Dynamic Characteristics** 

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
$C_{iss}$	Input Capacitance	$V_{GS} = 0V$		7410		
$C_{oss}$	Output Capacitance	$V_{\rm DS} = 25V$		1050		pF
$C_{rss}$	Reverse Transfer Capacitance	f = 1MHz		390		
$Q_{\mathrm{g}}$	Total gate Charge	$V_{GS} = 10V$		312		
$Q_{gs}$	Gate – Source Charge	$V_{Bus} = 250V$		37		nC
$Q_{\mathrm{gd}}$	Gate – Drain Charge	$I_D = 44A @ T_J = 25^{\circ}C$		127		
$T_{d(on)}$	Turn-on Delay Time	$V_{GS} = 15V$		18		
$T_{\rm r}$	Rise Time	$V_{\text{Bus}} = 13 \text{ V}$ $V_{\text{Bus}} = 250 \text{ V}$		16		
$T_{d(off)}$	Turn-off Delay Time	$I_D = 44A @ T_J = 25^{\circ}C$		54		ns
$T_{\rm f}$	Fall Time	$R_{\rm G} = 0.6\Omega$		5		

Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit	
$V_{\mathrm{F}}$	Diode Forward Voltage	$I_F = 30A$			1.6	1.8		
		$I_F = 60A$			1.9		V	
		$I_F = 30A$	$T_i = 125$ °C		1.4			
$I_{RM}$	Maximum Reverse Leakage Current	$V_{R} = 600V$	$T_i = 25$ °C			250	μΑ	
1RM		$V_{R} = 600V$	$T_{i} = 125^{\circ}C$			500		
$C_{T}$	Junction Capacitance	$V_R = 200V$			44		pF	
	Reverse Recovery Time	$I_F=1A, V_R=30V$ $di/dt = 100A/\mu s$	$T_j = 25$ °C		23		ns	
$t_{rr}$	Reverse Recovery Time		$T_i = 25^{\circ}C$		85			
		$T_i = 125$ °C		160				
$I_{RRM}$	Maximum Reverse Recovery Current	$I_F = 30A$ $V_R = 400V$	$T_j = 25$ °C		4		Α	
1RRM	Waximum Reverse Recovery Current		$T_{i} = 125^{\circ}C$		8		Λ	
0	Reverse Recovery Charge		$T_j = 25$ °C		130		nC	
$Q_{rr}$			$T_j = 125$ °C		700		IIC	
$t_{rr}$	Reverse Recovery Time	$I_F = 30A$ $V_R = 400V$ $di/dt = 1000A/\mu s$			70		ns	
Q <sub>rr</sub>	Reverse Recovery Charge		$T_j = 125$ °C		1300		nC	
$I_{RRM}$	Maximum Reverse Recovery Current				30		A	

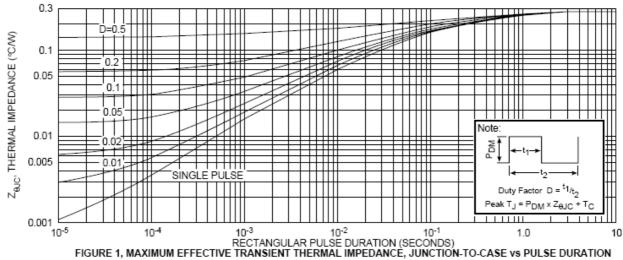
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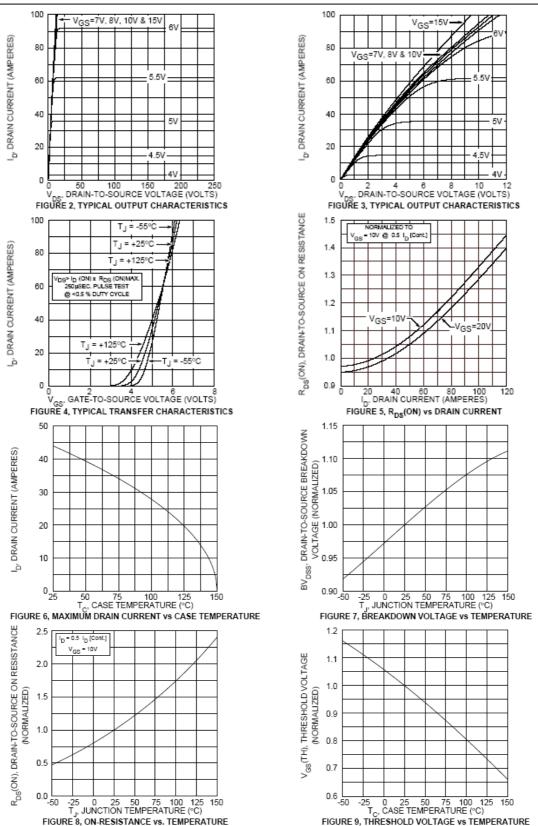
Thermal and package characteristics

Symbol	Characteristic		Min	Тур	Max	Unit
$R_{\text{thJC}}$	Junction to Case Thermal Resistance	MOSFET			0.28	
		Diode			1.21	°C/W
$R_{thJA}$	Junction to Ambient (IGBT & Diode)				20	
$V_{ISOL}$	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz		2500			V
$T_{J}, T_{STG}$	Storage Temperature Range		-55		150	°C
$T_{ m L}$	Max Lead Temp for Soldering:0.063" from case for 10 sec				300	C
Torque	Mounting torque (Mounting = 8-32 or 4mm Machine and terminals = 4mm Machine)				1.5	N.m
Wt	Package Weight			29.2		g

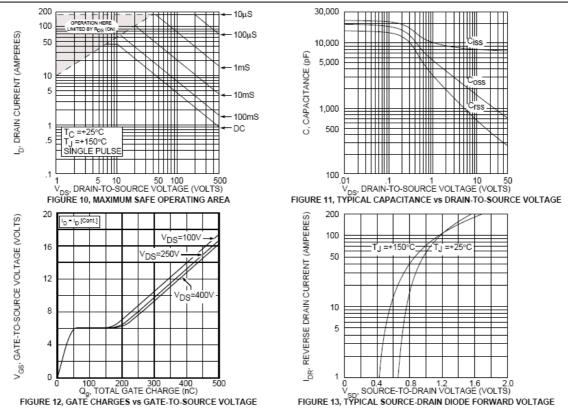
### **Typical MOSFET Performance Curve**



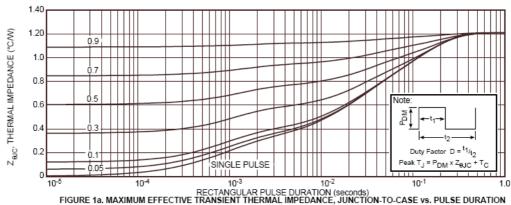








#### **Typical Diode Performance Curve**



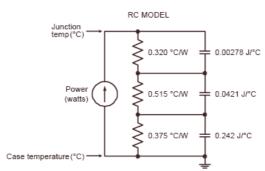


FIGURE 1b, TRANSIENT THERMAL IMPEDANCE MODEL

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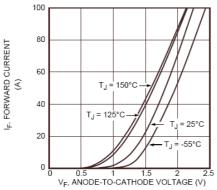


Figure 2. Forward Current vs. Forward Voltage

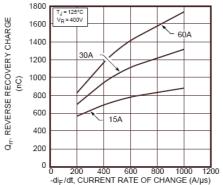


Figure 4. Reverse Recovery Charge vs. Current Rate of Change

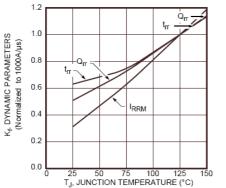


Figure 6. Dynamic Parameters vs. Junction Temperature

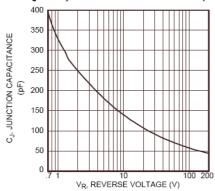


Figure 8. Junction Capacitance vs. Reverse Voltage

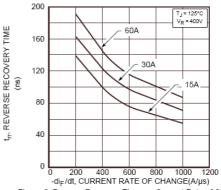


Figure 3. Reverse Recovery Time vs. Current Rate of Change

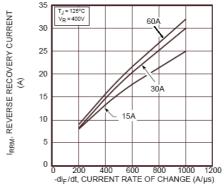


Figure 5. Reverse Recovery Current vs. Current Rate of Change

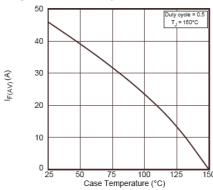


Figure 7. Maximum Average Forward Current vs. CaseTemperature



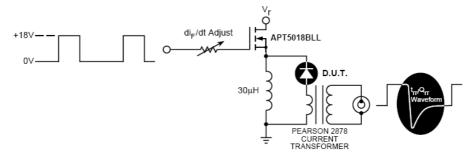
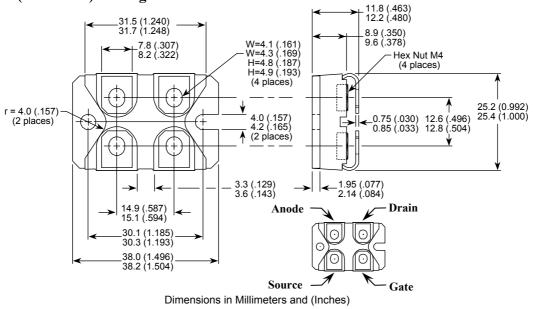


Figure 9. Diode Test Circuit

- 1 I<sub>F</sub> Forward Conduction Current
  2 di<sub>F</sub>/dt Rate of Diode Current Change Through Zero Crossing.
  3 I<sub>RRM</sub> Maximum Reverse Recovery Current.
  4 t<sub>Tf</sub> Reverse Recovery Time, measured from zero crossing where diode current goes from positive to negative, to the point at which the straight line through I<sub>RRM</sub> and 0.25•I<sub>RRM</sub> passes through zero.
- Q<sub>rr</sub> Area Under the Curve Defined by I<sub>RRM</sub> and t<sub>rr</sub>.

Figure 10, Diode Reverse Recovery Waveform and Definitions

### **SOT-227 (ISOTOP®) Package Outline**



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